



Project Number: Design Verification Test Report		Tracking Code: 105265_Report_Rev_1	
Requested by: Mark Shireman		Date: 9/30/2010	Product Rev: 0
Part #: SNT-100-YW-G / TSW-102-08-L-S		Lot #: na	Tech: Tony Wagoner Eng: Eric Mings
Part description: SNT			Qty to test: 5
Test Start: 9/26/2010	Test Completed: 9/28/2010		

DESIGN VERIFICATION TEST REPORT

SNT

SNT-100-YW-G / TSW-102-08-L-S

CERTIFICATION

All instruments and measuring equipment were calibrated to National Institute for Standards and Technology (NIST) traceable standards according to ISO 10012-1 and ANSI/NCSL 2540-1, as applicable.

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SCOPE

To perform the following tests: Design verification test. See test plan.

APPLICABLE DOCUMENTS

Standards: EIA Publication 364

TEST SAMPLES AND PREPARATION

- 1) All materials were manufactured in accordance with the applicable product specification.
- 2) All test samples were identified and encoded to maintain traceability throughout the test sequences.
- 3) Either an automated cleaning procedure or an ultrasonic cleaning procedure may be used.
- 4) The automated procedure is used with aqueous compatible soldering materials.
- 5) Any additional preparation will be noted in the individual test sequences.

FLOWCHARTS**Current Carrying Capacity****3 Mated Assemblies Each**

TEST STEP	GROUP A 3 Mated Assemblies 1 CONTACT POWERED
01	CCC

(TIN PLATING) - Tabulate calculated current at RT, 65° C, 75° C and 95° C
after derating 20% and based on 105° C

(GOLD PLATING) - Tabulate calculated current at RT, 85° C, 95° C and 115° C
after derating 20% and based on 125° C

CCC, Temp rise = EIA-364-70

ATTRIBUTE DEFINITIONS

The following is a brief, simplified description of attributes.

TEMPERATURE RISE (Current Carrying Capacity, CCC):

- 1) EIA-364-70, *Temperature Rise versus Current Test Procedure for Electrical Connectors and Sockets*.
- 2) When current passes through a contact, the temperature of the contact increases as a result of I^2R (resistive) heating.
- 3) The number of contacts being investigated plays a significant part in power dissipation and therefore temperature rise.
- 4) The size of the temperature probe can affect the measured temperature.
- 5) Copper traces on PC boards will contribute to temperature rise:
 - a. Self heating (resistive)
 - b. Reduction in heat sink capacity affecting the heated contacts
- 6) A de-rating curve, usually 20%, is calculated.
- 7) Calculated de-rated currents at three temperature points are reported:
 - a. Ambient
 - b. 80° C
 - c. 95° C
 - d. 115° C
- 8) Typically, neighboring contacts (in close proximity to maximize heat build up) are energized.
- 9) The thermocouple (or temperature measuring probe) will be positioned at a location to sense the maximum temperature in the vicinity of the heat generation area.
- 10) A computer program, *TR 803.exe*, ensures accurate stability for data acquisition.
- 11) Hook-up wire cross section is larger than the cross section of any connector leads/PC board traces, jumpers, etc.
- 12) Hook-up wire length is longer than the minimum specified in the referencing standard.

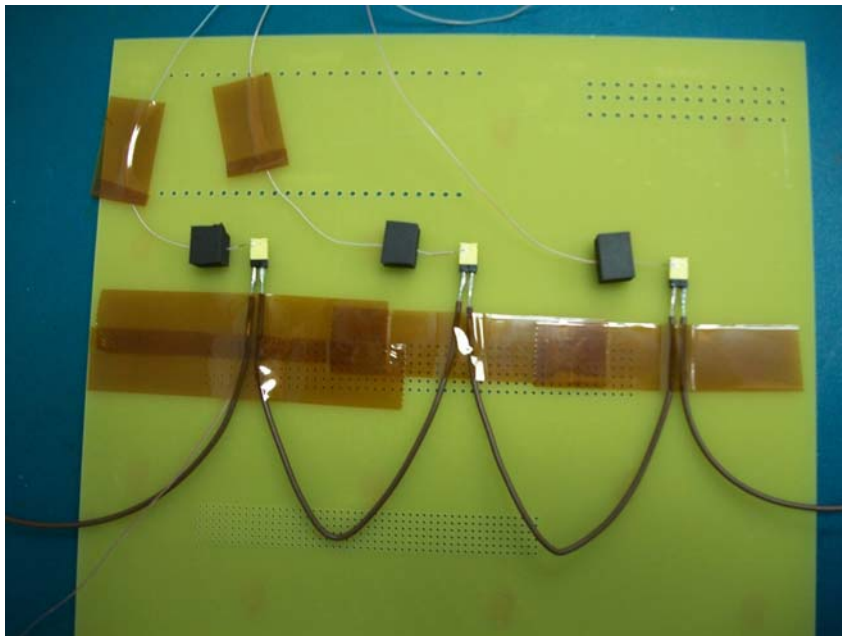


Fig 1
The set up for CCC

RESULTS

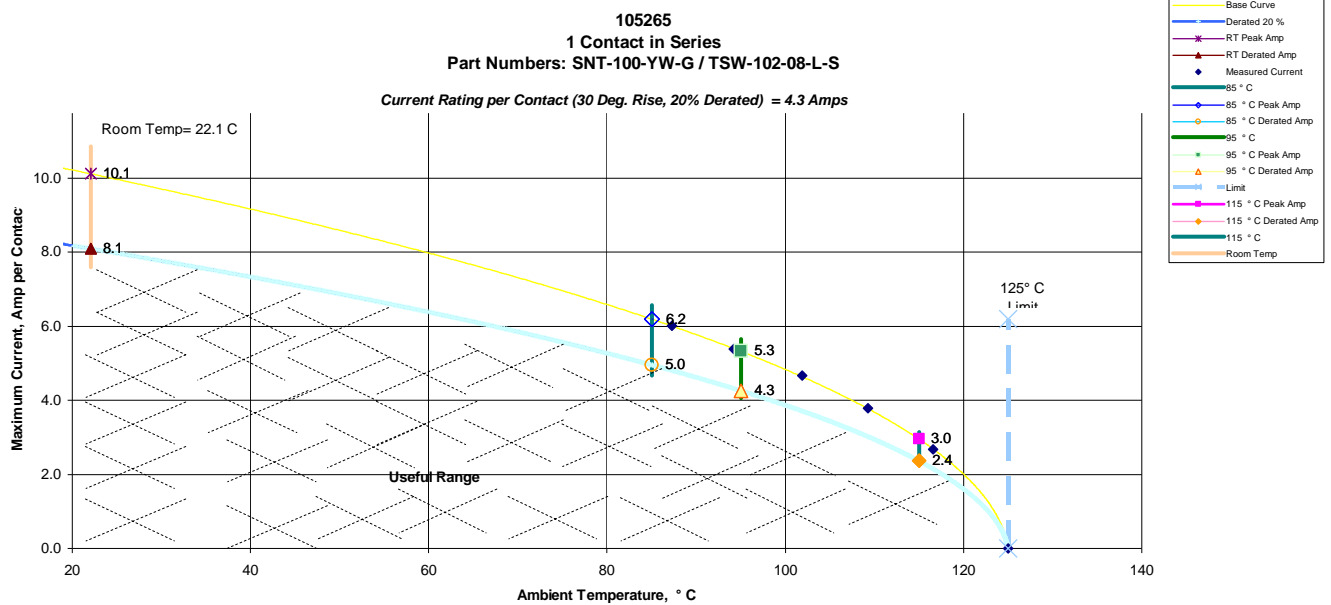
Temperature Rise, CCC at a 20% de-rating

- CCC for a 30°C Temperature Rise -----4.3A per contact with 1 adjacent contacts powered

DATA SUMMARIES

TEMPERATURE RISE - (Current Carrying Capacity, CCC):

- 1) High quality thermocouples whose temperature slopes track one another were used for temperature monitoring.
- 2) The thermocouples were placed at a location to sense the maximum temperature generated during testing.
- 3) Temperature readings recorded are those for which three successive readings, 15 minutes apart, differ less than 1° C (computer controlled data acquisition).
- 4) Adjacent contacts were powered:
 - a. Linear configuration with 1 adjacent conductors/contacts powered



EQUIPMENT AND CALIBRATION SCHEDULES**Equipment #:** MO-03**Description:** Multimeter /Data Acquisition System**Manufacturer:** Keithley**Model:** 2700**Serial #:** 0791975**Accuracy:** See Manual

... Last Cal: 06/16/10, Next Cal: 06/16/2011

Equipment #: PS-07**Description:** 20 V, 120 A DC Power Supply - AutoRanging SO/HPIB**Manufacturer:** Hewlett Packard / Agilent**Model:** AT-6031A**Serial #:** 2721A00648**Accuracy:** See Manual Current Carrying Capacity (CCC) Chamber

... Last Cal: 06/16/2010, Next Cal: 06/16/2011